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PATENT NUMBER
6546512 6546512

U.S. **UTILITY** Patent Application

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PATENT DATE

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SSUE CLASSIFICATION

Semigonductor integrated circuit having compression circuitry for compressing test data, and the test system and method for utilizing the semiconductor integrated circuit

PTO-2040 12/99

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ORIGINAL		CROSS REFERENCE(S)				
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**TERMINAL DRAWINGS CLAIMS ALLOWED** DISCLAIMER Sheets Drwg. Figs. Drwg. Print Fig. **Total Claims** Print Claim for O.G. 31. 5 2 14 NOTICE OF ALLOWANCE MAILED ☐ The term of this patent subsequent to (date) 9-5-02 has been disclaimed. 9-10 The term of this patent shall not extend beyond the expiration date ALBERT DECADY of U.S Patent. No. ISSIVE FEE SUPERVISORY PATENT EXAMINER Amount Due TECHNOLOGY CENTER 2100 Date Paid 1280.00 919/02 2-3-02 **ISSUE BATCH NUMBER** 

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The terminal \_\_\_\_months of this patent have been disclaimed.

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(Logdynstruments Examiner)

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FILED WITH: DISK (CRF) FICHE

Formal Drawings \_\_\_\_\_\_ sins) 35t\_\_\_\_\_

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